

Search Notes



Application/Control No.

10/616,604

Examiner

Hiep T. Nguyen

Applicant(s)/Patent under Reexamination

MASSE, WAYNE P.

Art Unit

2187

SEARCHED

Class	Subclass	Date	Examiner
711	173	8/4/05	H2
↓	112	↓	↓
↓	202	↓	↓
↓	208	↓	↓
707	205	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
711	173	8/4/05	H2

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST search list is attached	8/4/05	H2
NPL search using terms similar to EAST search.	↓	↓
Inventorship search	↓	↓